Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/711,845	BREITWISCH ET AL.	
Examiner	Art Unit	
Thien F. Tran	2811	

	SEARCHED		
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257	50, 530	4/14/2005	тт
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INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
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